Page 1 of 4 Applicant(s) Application No. PTO-1449 Daniel E. Evanicky, et al. Unimown 10/650030 Group Art Unit Filing Date Docket Number **Information Disclosure Citation** August 25, 2003 062986.0295 Unknown 2629 In an Application U.S. PATENT DOCUMENTS **SUBCLASS FILING DATE CLASS** DOCUMENT NO. DATE NAME 4,379,292 04/1983 Minato, et al. Α KMN 4,386,345 05/1983 Narveson, et al. В \overline{c} 4,912,558 03/1990 Easterly, et al. 10/1993 $\overline{\mathbf{D}}$ 5,250,937 Kikuo, et al. 03/29/1994 Ē 5,298,993 Edgar, et al. F 05/1994 5,315,378 Satou, et al. 06/10/1997 Engeldrum, et al. G 5,638,117 5,428,720 06/1995 Adams, Jr. H I 5,502,458 03/1996 Braudaway, et al. 10/1997 J 5,680,180 Huang \overline{K} 5,731,794 03/1998 Miyazawa 5,739,809 04/1998 McLaughlin, et al. L 04/1999 Awamoto, et al. M 5,898,414 06/1999 N 5,920,358 Takemura 0 5,926,239 07/1999 Kumar, et al. P 6,043,797 03/2000 Clifton, et al. **FOREIGN PATENT DOCUMENTS** TRANSLATION DOCUMENT NO. DATE **COUNTRY CLASS SUBCLASS** YES NO 96/01466 1/18/1996 PCT KMN 05/05/1993 EP 0539943 A1 R S 0562971 A1 09/29/1993 EP 0597797 A1 05/18/1994 T DATE DOCUMENT (Including Author, Title, Source, and Pertinent Pages) "White Balance Control Methods on Liquid Crystal Display", IBM Technical Disclosure Bulletin, MN Vol. 37, No. 11, Nov. 1, 1994, Page 425/426. DATE CONSIDERED /Kevin M. Nguyen/ 06/28/2006

EXAMINER

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